

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination AKIYAMA ET AL.	
		Examiner Danny Wai Lun Leung	Art Unit 2613	Page 1 of 1

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*	C	US-6,885,820 B2	04-2005	Eder et al.	398/26
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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.